

FCC Test Report

Report No.: NTEK-2014NT0328580F3

FCC ID: 2ABV9-T882

Product: 3G Smartphone

Trade Name: Cellacom

Model Number: T882

Serial Model: T882X (X stand for a-z)

Report No.: NTEK-2014NT0328580F3

Prepared for

Delang Electrnic(Jiangxi)Co.,Ltd.

De'an County Industrial Park, Jiujiang Jiangxi Province, China

Prepared by

Shenzhen NTEK Testing Technology Co., Ltd.

1/F, Building E, Fenda Science Park, Sanwei Community, Xixiang Street, Bao'an District, Shenzhen P.R. China

Tel.: +86-0755-61156588 Fax.: +86-0755-61156599 Website: www.ntek.org.cn



TEST RESULT CERTIFICATION

Report No.: NTEK-2014NT0328580F3

Applicant's name:	Delang E	lectrnic(Jiangxi)Co.,Ltd.
Address:		unty Industrial Park,Jiujiang Jiangxi Province,China
Manufacturer's Name:	SHENZH	EN TELACOM SCIENCE & TECHNOLOGY CO., LTD
Address:	7/F Block 1001, Xili	E2, TCL International E City, Zhong Shan Yuan Road , Bao'an District, Shenzhen,PRC
Product description		
Product name:	3G Smar	tphone
Model and/or type reference :	T882	
Standards:	FCC Part ANSI C63	115B:2012 3.4:2003
	n complian	sted by NTEK, and the test results show that the ace with Part 15 of FCC Rules. And it is applicable only to
document may be altered or rev	ised by N	t in full, without the written approval of NTEK, this TEK, personal only, and shall be noted in the revision of
Date of Test		
Date (s) of performance of tests		28 Mar. 2014 ~11 Apr. 2014
Date of Issue		11 Apr. 2014
Test Result	:	Pass
Testing Engine	eer :	Apple Huong
		(Apple Huang)
Technical Man	ager :	Brown Ln
		(Brown Lu)
Authorized Sig	inatory :	(Bovey Yang)



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1. TEST SUMMARY

Test procedures according to the technical standards:

EMC Emission							
Standard	Test Item Limit Judgment R						
FCC Part15B:2012	Conducted Emission	Class B	PASS				
ANSI C63.4: 2003	Radiated Emission	Class B	PASS				

NOTE:

- (1) 'N/A' denotes test is not applicable in this Test Report
- (2) For client's request and manual description, the test will not be executed.



1.1 TEST FACILITY

NTEK Testing Technology Co., Ltd

Add.: 1/F, Building E, Fenda Science Park, Sanwei Community, Xixiang Street, Bao'an District, Shenzhen P.R. China.

Report No.: NTEK-2014NT0328580F3

FCC Registration Number:238937; IC Registration Number:9270A-1

CNAS Registration Number:L5516

1.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement $\mathbf{y} \pm \mathbf{U}$, where expended uncertainty \mathbf{U} is based on a standard uncertainty multiplied by a coverage factor of $\mathbf{k=2}$, providing a level of confidence of approximately 95 %.

A. Conducted Measurement:

Test Site	Method	Measurement Frequency Range	U , (dB)	NOTE
NTEKC01	ANSI	150 KHz ~ 30MHz	3.2	

B. Radiated Measurement:

Test Site	Method	Measurement Frequency Range	U , (dB)	NOTE
NTEKA01	ANSI	30MHz ~ 1000MHz	4.7	
		1GHz ~6GHz	5.0	



2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF EUT

Equipment	3G Smartphone			
Model Name	T882			
Additional Model	T882X (X stand for a-z)			
Number(s)	1002A (A Stariu IOI a-2)			
Model Difference	All the model are the same circuit and RF module, except the model name and colour.			
	The EUT is a 3G Smartphone.			
	Connecting I/O port: USB			
Product Description	Based on the application, features, or specification exhibited in User's Manual, the EUT is considered as an ITE/Computing Device. More details of EUT technical specification, please refer to the User's Manual.			
Power Source	DC Voltage			
Adapter	Input: 100-240V~			
,	Output: 5.0V===,1000mA			
Battery	DC3.7V, 2000mAh			



2.1.1 DESCRIPTION OF TEST MODES

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

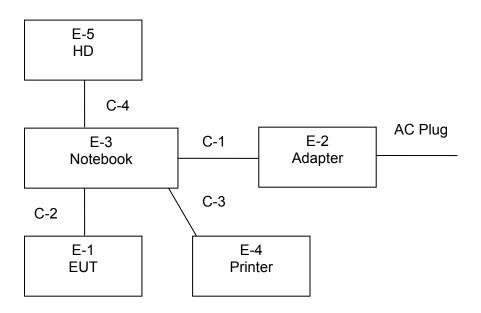
Pretest Mode	Description
Mode 1	Downloading

For Conducted Test				
Final Test Mode Description				
Mode 1	Downloading			

For Radiated Test				
Final Test Mode Description				
Mode 1	Downloading			



2.2 DESCRIPTION OF TEST SETUP





2.3 DESCRIPTION TEST PERIPHERAL AND EUT PERIPHERAL

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Brand	Model/Type No.	Series No.	Note
E-1	3G Smartphone	Cellacom	T882	N/A	EUT
E-2	ADAPTER	Lenovo	ThinkPad Edge E430	N/A	
E-3	Notebook	Lenovo	ADLX90NCT3A	N/A	
E-4	Printer	Canon	L11121E	LBP2900	
E-5	HD	Buffalo inc.	HD-PET320U2	55571500924085	

Item	Shielded Type	Ferrite Core	Length	Note
C-1	NO	NO	0.8m	
C-2	NO	NO	1.2m	
C-3	NO	NO	0.8m	
C-4	NO	NO	1.2m	

Note:

- The support equipment was authorized by Declaration of Confirmation. (1)
- For detachable type I/O cable should be specified the length in cm in <code>『Length』</code> column. (2)
- "YES" means "shielded" "with core"; "NO" means "unshielded" "without core". (3)



2.4 MEASUREMENT INSTRUMENTS LIST

2.4.1 CONDUCTED TEST SITE

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibra tion period
1	LISN	R&S	ENV216	101313	Jul. 06, 2013	Jul. 05, 2014	1 year
2	LISN	SCHWARZBE CK	NNLK 8129	8129245	Dec. 25, 2013	Dec. 24, 2014	1 year
3	Pulse Limiter	SCHWARZBE CK	VTSD 9561F	9716	Dec. 25, 2013	Dec. 24, 2014	1 year
4	50Ω Switch	ANRITSU CORP	MP59B	6200983704	Jul. 06, 2013	Jul. 05, 2014	1 year
5	Test Cable	N/A	C01	N/A	Jul. 06, 2013	Jul. 05, 2014	1 year
6	Test Cable	N/A	C02	N/A	Jul. 06, 2013	Jul. 05, 2014	1 year
7	Test Cable	N/A	C03	N/A	Jul. 06, 2013	Jul. 05, 2014	1 year
8	EMI Test Receiver	R&S	ESCI	101160	Jul. 06, 2013	Jul. 05, 2014	1 year
9	Passive Voltage Probe	ESH2-Z3	R&S	100196	Jul. 06, 2013	Jul. 05, 2014	1 year
10	Triple-Loop Antenna	EVERFINE	LIA-2	11020003	Jul. 06, 2013	Jul. 05, 2014	1 year
11	Absorbing Clamp	R&S	MDS-21	100423	Jul. 08, 2013	Jul. 07, 2014	1 year

2.4.2 RADIATED TEST SITE

4.4.2	.4.2 RADIATED TEST SITE							
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibra tion period	
1	Bilog Antenna	TESEQ	CBL6111D	31216	Jul. 06, 2013	Jul. 05, 2014	1 year	
2	Test Cable	N/A	R-01	N/A	Dec. 25, 2013	Dec. 24, 2014	1 year	
3	Test Cable	N/A	R-02	N/A	Dec. 25, 2013	Dec. 24, 2014	1 year	
4	EMI Test Receiver	R&S	ESCI-7	101318	Jul. 06, 2013	Jul. 05, 2014	1 year	
5	Antenna Mast	EM	SC100_1	N/A	N/A	N/A	N/A	
6	Turn Table	EM	SC100	060531	N/A	N/A	N/A	
7	50Ω Switch	Anritsu Corp	MP59B	6200983705	Jul. 06, 2013	Jul. 05, 2014	1 year	
8	Spectrum Analyzer	Aglient	E4407B	MY45108040	Jul. 06, 2013	Jul. 05, 2014	1 year	
9	Horn Antenna	EM	EM-AH-10180	2011071402	Jul. 06, 2013	Jul. 05, 2014	1 year	
10	Amplifier	EM	EM-30180	060538	Jul. 06, 2013	Jul. 05, 2014	1 year	



3. EMC EMISSION TEST

3.1 CONDUCTED EMISSION MEASUREMENT

3.1.1 POWER LINE CONDUCTED EMISSION (Frequency Range 150KHz-30MHz)

FREQUENCY (MHz)	Class A	(dBuV)	Class B (dBuV)		
PREQUENCT (MITZ)	Quasi-peak	Average	Quasi-peak	Average	
0.15 -0.5	79.00	66.00	66 - 56 *	56 - 46 *	
0.50 -5.0	73.00	60.00	56.00	46.00	
5.0 -30.0	73.00	60.00	60.00	50.00	

Note:

- (1) The tighter limit applies at the band edges.
- (2) The limit of " * " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.

The following table is the setting of the receiver

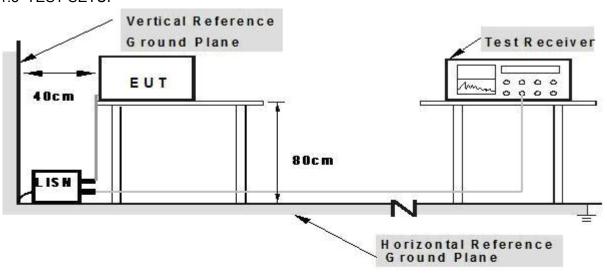
Receiver Parameters	Setting
Attenuation	10 dB
Start Frequency	0.15 MHz
Stop Frequency	30 MHz
IF Bandwidth	9 kHz



3.1.2 TEST PROCEDURE

- a. The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d. LISN at least 80 cm from nearest part of EUT chassis.
- e. For the actual test configuration, please refer to the related Item -EUT Test Photos.

3.1.3 TEST SETUP



Note: 1. Support units were connected to second LISM.

2.Both of LISNs (AMN) are 80 cm from EUT and at least 80 from other units and other metal planes

3.1.4 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of **2.3** Unless otherwise a special operating condition is specified in the follows during the testing.

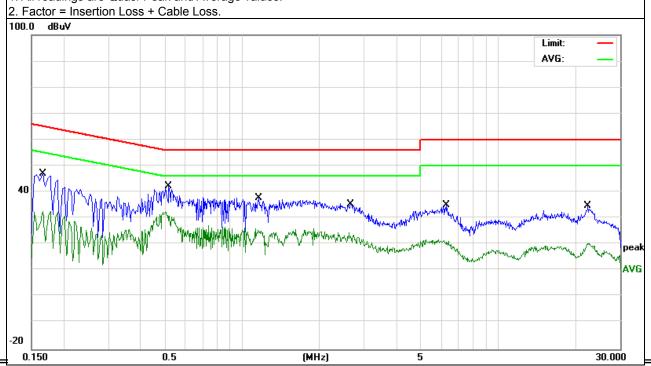


3.1.5 TEST RESULTS

EUT:	3G Smartphone	Model Name. :	T882			
Temperature :	26 ℃	Relative Humidity:	54%			
Pressure:	1010hPa	Test Date :	2014-04-11			
Test Mode:	Mode 1	Phase :	L			
Test Voltage :	DC 5V From Notebook AC 120V/60Hz					

Frequency	Reading Level	Correct Factor	Measure-ment	Limits	Margin	Dotostor Typo
(MHz)	(dBµV)	(dB)	B) (dBµV)		(dB)	Detector Type
0.1660	37.51	9.61	47.12	65.15	-18.03	AVG
0.1660	23.07	9.61	32.68	55.15	-22.47	QP
0.5180	32.67	9.53	42.20	56.00	-13.80	QP
0.5180	22.79	9.53	32.32	46.00	-13.68	AVG
1.1620	28.13	9.55	37.68	56.00	-18.32	QP
1.1620	16.43	9.55	25.98	46.00	-20.02	AVG
2.6540	25.83	9.57	35.40	56.00	-20.60	QP
2.6540	14.93	9.57	24.50	46.00	-21.50	AVG
6.2938	25.31	9.64	34.95	60.00	-25.05	QP
6.2938	11.82	9.64	21.46	50.00	-28.54	AVG
22.4900	24.46	10.23	34.69	60.00	-25.31	QP
22.4900	10.22	10.23	20.45	50.00	-29.55	AVG

Remark:



^{1.} All readings are Quasi-Peak and Average values.

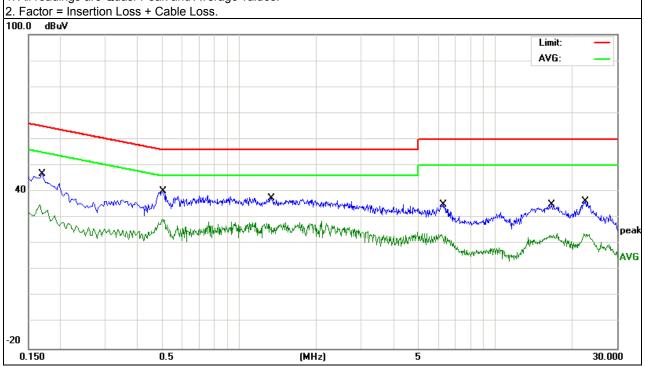


EUT:	3G Smartphone	Model Name. :	T882		
Temperature :	26 ℃	Relative Humidity:	54%		
Pressure :	1010hPa	Test Date :	2014-04-11		
Test Mode:	Mode 1	Phase :	N		
Test Voltage :	DC 5V From Notebook AC 120V/60Hz				

Frequency	Reading Level	Correct Factor	Measure-ment	Limits	Margin	Detector Type
(MHz)	(dBµV)	(dB)	(dBµV)	(dBµV)	(dB)	Detector Type
0.1700	37.22	9.59	46.81	64.96	-18.15	QP
0.1700	25.48	9.59	35.07	54.96	-19.89	AVG
0.5060	30.62	9.53	40.15	56.00	-15.85	QP
0.5060	19.68	9.53	29.21	46.00	-16.79	AVG
1.3380	27.78	9.56	37.34	56.00	-18.66	QP
1.3380	18.30	9.56	27.86	46.00	-18.14	AVG
6.2738	25.52	9.64	35.16	60.00	-24.84	QP
6.2738	14.14	9.64	23.78	50.00	-26.22	AVG
16.6099	25.02	9.95	34.97	60.00	-25.03	QP
16.6099	14.06	9.95	24.01	50.00	-25.99	AVG
22.5740	25.97	10.24	36.21	60.00	-23.79	QP
22.5740	13.56	10.24	23.80	50.00	-26.20	AVG

Remark:

1. All readings are Quasi-Peak and Average values.





3.2 RADIATED EMISSION MEASUREMENT

3.2.1 LIMITS OF RADIATED EMISSION MEASUREMENT

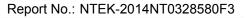
FREQUENCY (MHz)	Class A (at 10m)	Class B (at 3m)
PREQUENCY (WITZ)	dBuV/m	dBuV/m
30 ~ 88	39.0	40.0
88 ~ 216	43.5	43.5
216 ~ 960	46.5	46.0
Above 960	49.5	54.0

Notes:

- (1) The limit for radiated test was performed according to as following: FCC PART 15B /ICES-003.
- (2) The tighter limit applies at the band edges.
- (3) Emission level (dBuV/m)=20log Emission level (uV/m).

3.2.2 TEST PROCEDURE

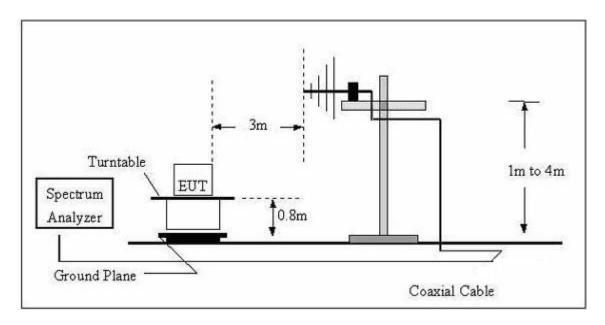
- a. The measuring distance of at 10 m shall be used for measurements at frequency up to 1GHz. For frequencies above 1GHz, any suitable measuring distance may be used.
- b. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 10 meter open area test site. The table was rotated 360 degrees to determine the position of the highest radiation.
- c. The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. The initial step in collecting conducted emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured, above 1G Average detector mode will be instead
- e. If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP(AV) Limits and then no additional QP Mode measurement performed.
- f. For the actual test configuration, please refer to the related Item –EUT Test Photos.



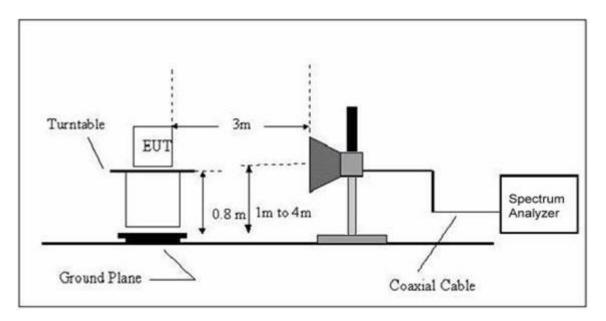


3.2.3 TEST SETUP

(A) Radiated Emission Test Set-Up Frequency Below 1 GHz



(B) Radiated Emission Test Set-Up Frequency Above 1GHz



3.2.4 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of **2.3** Unless otherwise a special operating condition is specified in the follows during the testing.



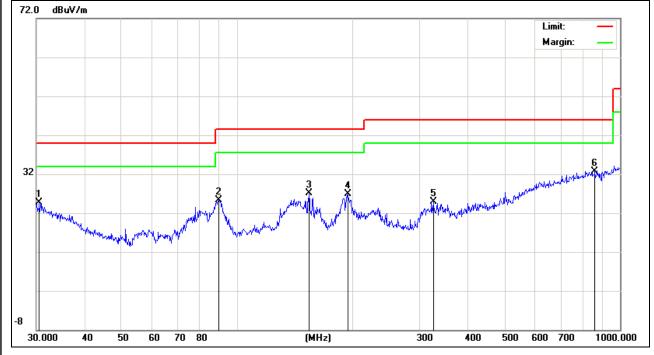
3.2.5 TEST RESULTS

EUT:	3G Smartphone	Model Name :	T882			
Temperature :	24 ℃	Relative Humidity:	54%			
Pressure :	1010 hPa	Test Date :	2014-04-11			
Test Mode :	Mode 1	Polarization :	Horizontal			
Test Power :	DC 5V From Notebook AC 120V/60Hz					

Freq.	Reading	Factor	Measurement	Limit	Over	Detector
(MHz)	(dBuV)	(dBuV)	(dBuV)	(dBuV)	(dB)	Detector
30.5305	5.88	18.76	24.64	40.00	-15.36	QP
89.9047	16.62	8.76	25.38	43.50	-18.12	QP
154.2786	16.35	10.79	27.14	43.50	-16.36	QP
195.1365	18.61	8.21	26.82	43.50	-16.68	QP
325.5957	9.51	15.48	24.99	46.00	-21.01	QP
860.0352	9.61	23.06	32.67	46.00	-13.33	QP

Remark:

- 1. All readings are Peak and Average values.
- 2. Factor = Antenna Factor + Cable Loss Amplifier.
- 3. N/A means All Data have pass Limit





EUT: 3G Smartphone Model Name : T882 Temperature: **24** ℃ Relative Humidity: 54% Pressure: 1010 hPa Test Date: 2014-04-11 Test Mode : Mode 1 Polarization: Vertical Test Power : DC 5V From Notebook AC 120V/60Hz

Report No.: NTEK-2014NT0328580F3

Freq.	Reading	Factor	Measurement	Limit	Over	Detector
(MHz)	(dBuV)	(dBuV)	(dBuV)	(dBuV)	(dB)	Detector
30.1053	15.47	18.98	34.45	40.00	-5.55	QP
36.1272	16.22	15.91	32.13	40.00	-7.87	QP
77.8653	19.26	8.57	27.83	40.00	-12.17	QP
89.5899	20.23	8.84	29.07	43.50	-14.43	QP
198.5879	17.74	7.54	25.28	43.50	-18.22	QP
866.0878	9.50	22.88	32.38	46.00	-13.62	QP

Remark:

- 1. All readings are Peak and Average values.
- 2. Factor = Antenna Factor + Cable Loss Amplifier.
- 3. N/A means All Data have pass Limit





3.2.6 TEST RESULTS(Above 1GHz)

Polar	Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Detector
(H/V)	(MHz)	(dBm)	(dB)	(dBm)	(dBm)	(dB)	Туре
V	1187.688	69.55	-18.27	51.28	74	-22.72	peak
V	1636.784	67.6	-16.06	51.54	74	-22.46	peak
V	2453.883	68.65	-12.91	55.74	74	-18.26	peak
V	2453.883	51.46	-12.91	38.55	54	-15.45	AVG
Н	2099.687	68.18	-11.84	56.34	74	-17.66	peak
Н	2099.687	51.31	-11.84	39.47	54	-14.53	AVG
Н	2502.727	70.49	-12.73	57.76	74	-16.24	peak
Н	2502.727	55.39	-12.73	42.66	54	-11.34	AVG
Н	4155.567	66.57	-6.08	60.49	74	-13.51	peak
Н	4155.567	46.71	-6.08	40.63	54	-13.37	AVG

Remark:

Absolute Level= ReadingLevel+ Factor, Margin= Absolute Level - Limit



4. EUT TEST PHOTO



